Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/695,803	SARWARY ET AL.
Examiner	Art Unit
Sun J. Lin	2825

SEARCHED					
Class	Subclass	Date	Examiner		
716	6	2/3/2006	JSL		
716	1	2/3/2006	JSL		
716	4	2/3/2006	JSL		
716	5	2/3/2006	JSL		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
716	6	2/3/2006	JSL	
716	1	2/3/2006	JSL	
716	5	2/3/2006	JSL	

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
EAST {USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB}	2/3/2006	JSL
IEEE	2/3/2006	JSL
GOOGLE	2/3/2006	JSL